

Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low capacitances
- Avalanche Ruggednes

Applications

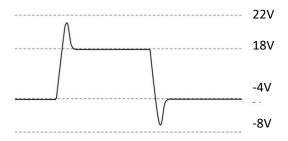
- Solar Inverters
- Switch Mode Power Supplies
- Auxiliary power supplies
- · Smart meters

Ordering Part Number	Package	Qty(PCS)	
MSC750SMA170SA	TO-263-7L	50	RoHS Post

Maximum Ratings (Tc = 25 °C unless otherwise specifed)

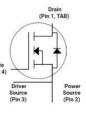
Parameter	Symbol	Value	Unit
Drain-source voltage	Vds	1700	V
Continuous drain current Tc = 25°C Tc = 100°C	lo	6.7 5	A
Pulsed drain current (Tc = 25° C, t _P limited by T _{jmax})	D pulse	16.7	А
Avalanche energy, single pulse (L=10mH)	Eas	1000	mJ
Gate-Source voltage	Vgs	-4/+18	V
Gate-Source voltage (dynamic,Absolute maximum values)	VGSmax	-8/+22	V
Power dissipation (Tc = 25°C)	Ptot	86	W
Operating junction and storage temperature	Tj,Tstg	-55+175	°C

• Example of acceptable Vgs waveform





TO-263-7L Package





Thermal Resistance

Parameter	Symbol	Value	Unit
Thermal resistance, junction – case. Max	RthJC	1.7	°C/W
Thermal resistance, junction – ambient. Max	RthJA	40	0/11

Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
	Symbol	min.	typ.	max.	Unit	Test Condition
Static Characteristic						
Drain-source breakdown voltage	BVDSS	1700	-	-	V	Vgs=0V, Id=100uA
Gate threshold voltage	VGS(th)	1.8	3	4.5	V	Vds=Vgs,Id=380uA
Zero gate voltage drain current	Idss	-	1 5	10 -	μA	V _{DS} =1700V,V _{GS} =0V T _j =25°C T _j =175°C
Gate-source leakage current	lgss	-		100	nA	Vgs=20V,Vds=0V
Drain-source on-state resistance	RDS(on)	-	700 1280	910 -	m	Vgs=18V,ID=1A, Tj=25°C Tj=175°C
Dynamic Characteristic			1			
Input Capacitance	Ciss	-	285	-		Vps = 1000V
Output Capacitance	Coss	-	15.3	-	pF	Vgs = 0V TJ = 25°C
Reverse Transfer Capacitance	Crss	-	2.2	-		V _{AC} = 25mV f = 1MHz
Gate Total Charge	QG	-	16.5	-		Vps =1000V
Gate-Source charge	Qgs	-	2.7	-	nC	Vgs =-5/18V Ip =1A
Gate-Drain charge	Q _{gd}	-	12.5	-		ID = IA
Turn-On Switching Energy	Eon	-	73.9	-	μJ	
Turn-Off Switching Energy-	EOFF	-	20.4		μυ	Vdd =1000V
Turn-on delay time	t d(on)	-	6.2	-		VGS = -3.5/+18V ID =2A RG =10
Rise time	tr	-	13.7	-		
Turn-off delay time	td(off)	-	9.4	-	ns	L=1880uH
Fall time	tr	-	45.4	-		
Gate resistance	Rg	-	18	-		Vac = 25mV, f=1MHz



Body Diode Characteristic

Parameter	Symbol	Value		Unit	Test Condition	
	Symbol	min.	typ.	max.	Onit	Test condition
Body Diode Forward Voltage	Vsd		4		V	V _G s=0V,I _{SD} =1A, T _J =25°C
Body Diode Forward Voltage	VSD		3.8		V	Vgs=0V,Isd=1A, Tj=175°C
Body Diode Reverse Recovery Time	trr	-	33.5	-	ns	$V_{R} = 1000V,$ $V_{GS} = -3.5V/+18V$ $I_{D} = 2A, R_{g} = 30$
Body Diode Reverse Recovery Charge	Qrr	-	56.1	-	nC	$di/dt = 1000A/\mu S$ L = 1880uH



Typical Performance Characteristics

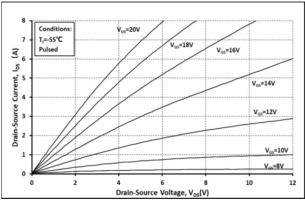


Fig 1. Output Characteristic (T_J=-55°C)

Fig 3. Output Characteristic (T_J=175℃)

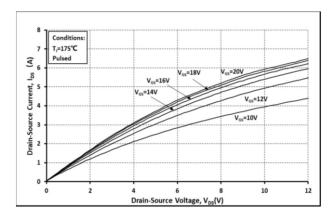
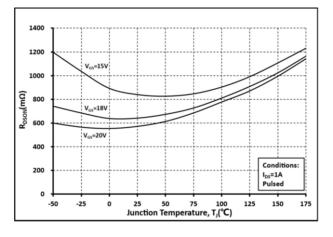
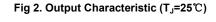


Fig 5: Rds(on) vs. Temperature





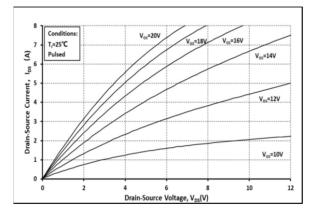
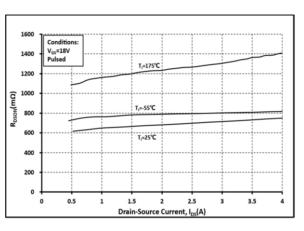
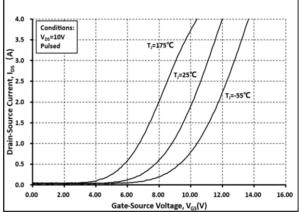


Fig 4: Rdson Vs Ids Characteristic









-6 -5 -4 -3 -2 -1 0 U₀₀=-5V V₀₀=-5V V₀₀=-5V V₀₀=0V -1 -2 -3 -3 -4 -3 -2

Drain-Source Voltage, V_{DS}(V)

Fig 7: Body-diode Characteristic (T_J=-55°C)



Pulsed

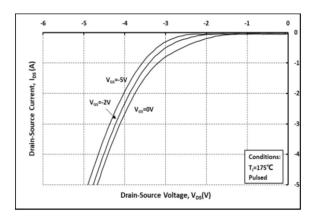


Fig 11: Gate Charge Characteristics

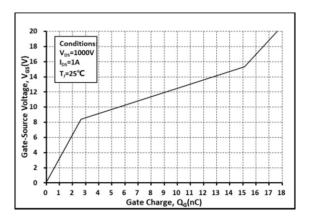


Fig 8: Body-diode Characteristic (TJ=25℃)

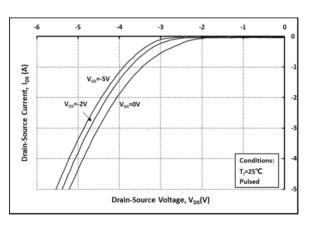


Fig 10: V_{TH} Vs T_J Temperature Characteristic

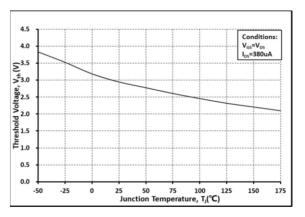


Fig 12: 3rd Quadrant Characteristic(T_J=-55°C)

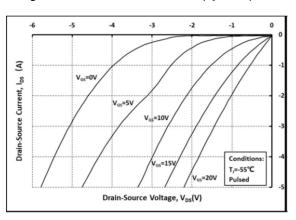




Fig 13: 3rd Quadrant Characteristic(T_J=25°C)

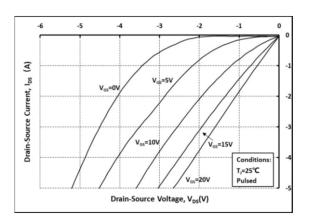
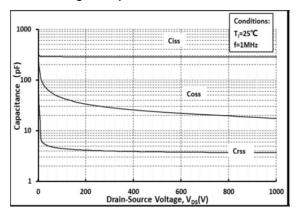


Fig 15: Capacitance Characteristic





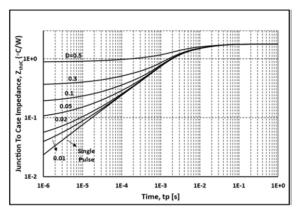


Fig 14: 3rd Quadrant Characteristic(T_J=175℃)

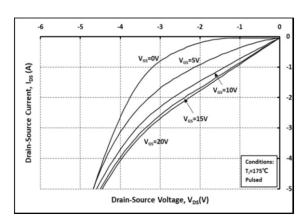
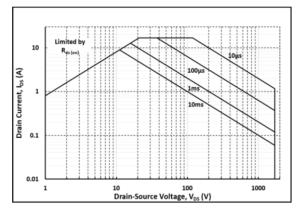


Fig 16: Safe Operating Area





Test Circuit Schematic

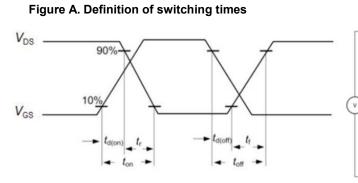


Figure B. Dynamic test circuit

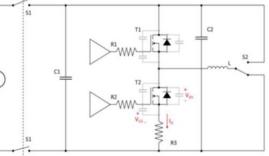


Figure C. Definition of body diodeswitching characteristics

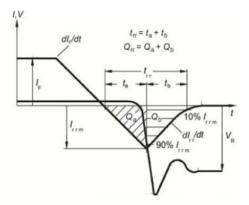


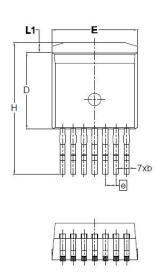
Figure C. Definition of diode switching characteristics

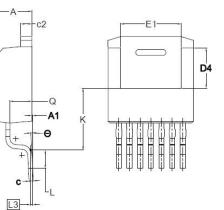


MSC750SMA170SA SiC Power MOSFET N-Channel Enhancement Mode

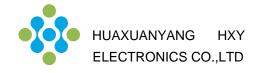
Package Dimensions

Package TO-263-7L





SYMBOL	C.	DIMENSION	S	
SYMBOL	MIN.	NOM.	MAX.	
A	4.30	4.40	4.50	
A1	0.00	0.10	0.25	
b	0.50	0.60	0.70	
c	0.45	0.50	0.60	
c2	1.20	1.30	1.40	
D	8.93	9.08	9.23	
D4	4.65	4.80	4.95	
E	10.08	10.18	10.28	
E1	6.82	7.22	7.62	
e	1.27 BSC			
н	15.00 15.70		16.00	
к	7.30			
L	1.90	2.20	2.50	
L1	1.00	1.20	1.40	
L3	0.25 BSC			
Q	2.45	2.60	2.75	
Θ	0°	3°	7°	



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